

**GaAlAs-Infrarot-Sendediode**  
**GaAlAs-Infrared Emitter**  
**Lead (Pb) Free Product - RoHS Compliant**

**IRL 81 A**



**Wesentliche Merkmale**

- GaAlAs-Lumineszenzdiode im nahen Infrarotbereich
- Rosa Kunststoff-Miniaturgehäuse, seitliche Abstrahlung
- Preisgünstig
- Lange Lebensdauer (Langzeitstabilität)
- Weit Öffnungskegel ( $\pm 25^\circ$ )
- Passend zu Fototransistor LPT 80 A

**Anwendungen**

- Fertigungs- und Kontrollanwendungen der Industrie, die eine Unterbrechung des Lichtstrahls erfordern
- Lichtschranken

**Features**

- GaAlAs infrared emitting diode in the near infrared range
- Pink plastic package with lateral emission
- Cost-effective
- Long-term stability
- Wide beam ( $\pm 25^\circ$ )
- Matches phototransistor LPT 80 A

**Applications**

- For a variety of manufacturing and monitoring applications which require beam interruption
- Light barriers

Typ Type	Bestellnummer Ordering Code	Gehäuse Package
IRL 81 A	Q68000A8000	Hellrot eingefärbtes Kunststoffgehäuse, seitliche Abstrahlung, Anschlüsse im 2,54 mm-Raster Light-red colored plastic package, sidelooker, solder tabs 2.54 mm ( $\frac{1}{10}$ ")

**Grenzwerte ( $T_A = 25^\circ\text{C}$ )****Maximum Ratings**

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Betriebs- und Lagertemperatur Operating and storage temperature range	$T_{\text{op}}; T_{\text{stg}}$	- 40 ... + 100	°C
Sperrspannung Reverse voltage	$V_R$	5	V
Durchlassstrom Forward current	$I_F$	100	mA
Verlustleistung Power dissipation	$P_{\text{tot}}$	200	mW
Wärmewiderstand Thermal resistance	$R_{\text{thJA}}$	375	K/W

**Kennwerte ( $T_A = 25^\circ\text{C}$ )****Characteristics**

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Wellenlänge der Strahlung bei $I_{\text{max}}$ Wavelength of peak emission	$\lambda_{\text{peak}}$	880	nm
Spektrale Bandbreite bei 50% von $I_{\text{max}}$ Spectral bandwidth at 50% of $I_{\text{max}}$	$\Delta\lambda$	80	nm
Abstrahlwinkel Half angle	$\phi$	± 25	Grad deg.
Aktive Chipfläche Active chip area	$A$	0.09	mm <sup>2</sup>
Abmessungen der aktiven Chipfläche Dimension of the active chip area	$L \times B$ $L \times W$	0.3 × 0.3	mm <sup>2</sup>
Schaltzeiten, $I_e$ von 10% auf 90% und von 90% auf 10%, bei $I_F = 100$ mA, $R_L = 50 \Omega$ Switching times, $I_e$ from 10% to 90% and from 90% to 10%, $I_F = 100$ mA, $R_L = 50 \Omega$	$t_r, t_f$	0.6/0.5	μs
Kapazität Capacitance $V_R = 0$ V, $f = 1$ MHz	$C_o$	15	pF
Durchlassspannung, $I_F = 20$ mA Forward voltage	$V_F$	1.5 ( $\leq 2.0$ )	V

**Kennwerte ( $T_A = 25^\circ\text{C}$ )****Characteristics (cont'd)**

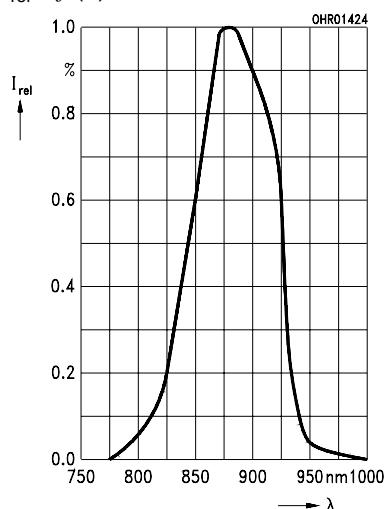
Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Gesamtstrahlungsfluss, $I_F = 20 \text{ mA}$ Total radiant flux	$\Phi_e$	5	mW
Sperrstrom Reverse current $V_R = 5 \text{ V}$	$I_R$	0.01 ( $\leq 1$ )	$\mu\text{A}$
Temperaturkoeffizient von $I_e$ bzw. $\Phi_e$ , $I_F = 100 \text{ mA}$ Temperature coefficient of $I_e$ or $\Phi_e$ , $I_F = 100 \text{ mA}$	$TC_I$	- 0.5	%/K
Temperaturkoeffizient von $V_F$ , $I_F = 100 \text{ mA}$ Temperature coefficient of $V_F$ , $I_F = 100 \text{ mA}$	$TC_V$	- 2	mV/K
Temperaturkoeffizient von $\lambda$ , $I_F = 100 \text{ mA}$ Temperature coefficient of $\lambda$ , $I_F = 100 \text{ mA}$	$TC_\lambda$	0.25	nm/K

**Strahlstärke  $I_e$  in Achsrichtung**gemessen bei einem Raumwinkel  $\Omega = 0.01 \text{ sr}$ **Radiant Intensity  $I_e$  in Axial Direction**at a solid angle of  $\Omega = 0.01 \text{ sr}$ 

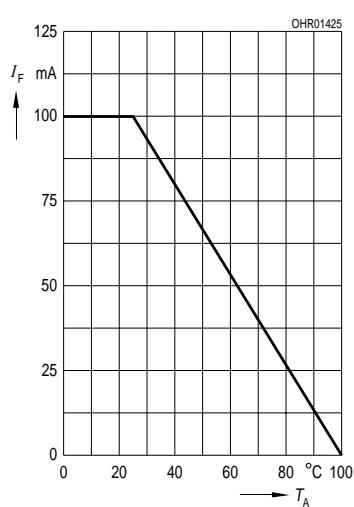
Bezeichnung Parameter	Symbol	Werte Values	Einheit Unit
Strahlstärke Radiant intensity $I_F = 20 \text{ mA}, t_p = 20 \text{ ms}$	$I_{e \min}$ $I_{e \text{ typ}}$	1.0 2.5	mW/sr mW/sr

**Relative Spectral Emission**

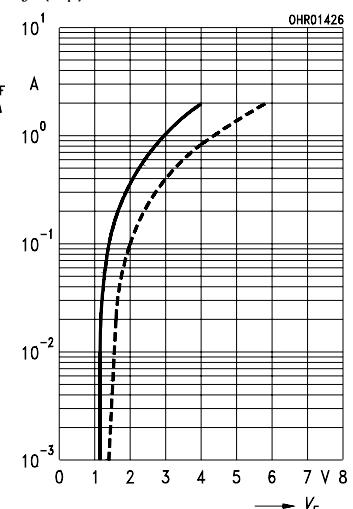
$$I_{\text{rel}} = f(\lambda)$$

**Max. Forward Current**

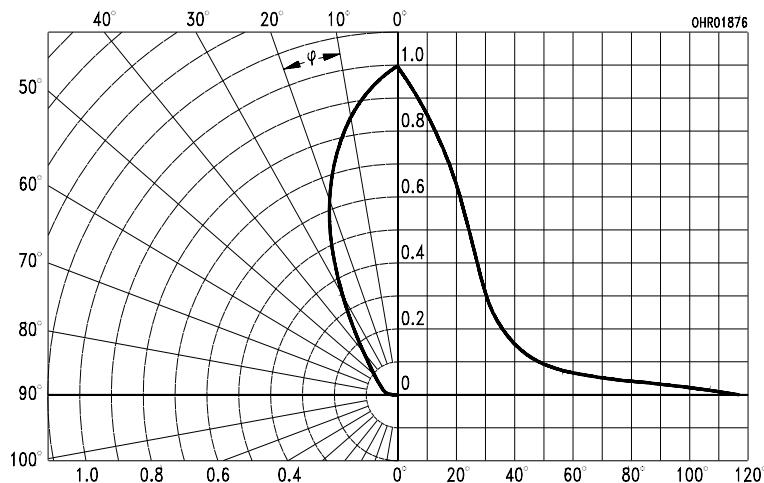
$$I_F = f(T_A)$$

**Forward Current**

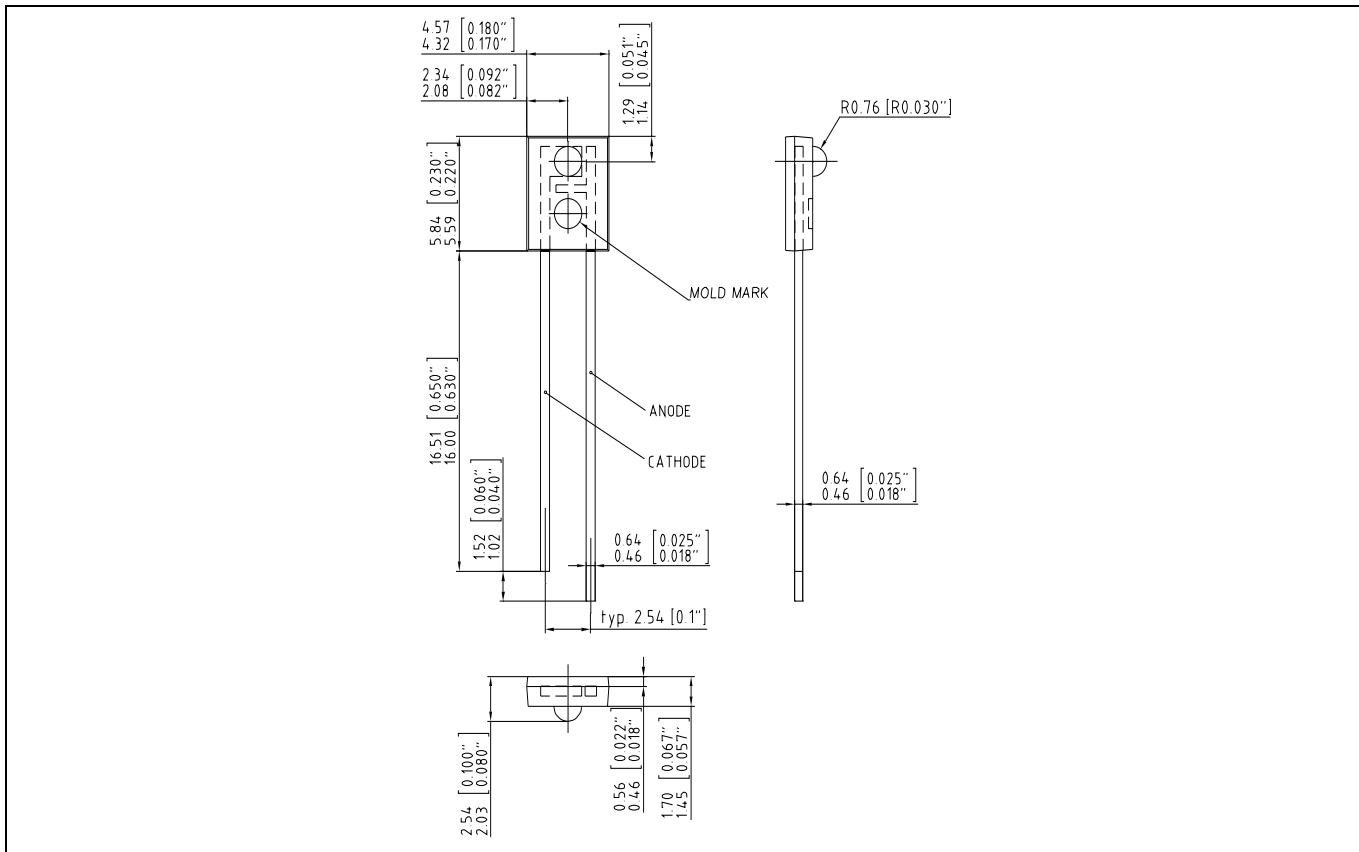
$$I_F = f(V_F)$$

**Directional Characteristics**

$$I_{\text{rel}} = f(\varphi)$$



## Maßzeichnung Package Outlines

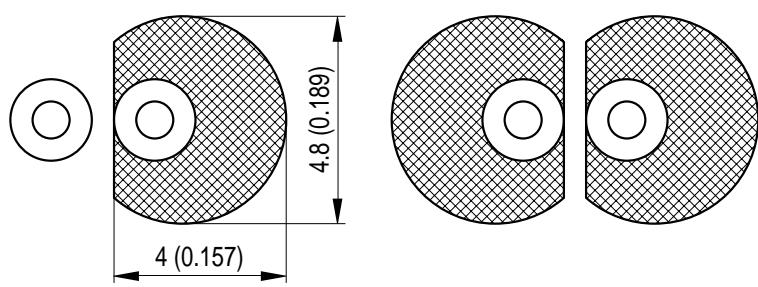


Maße in mm (inch) / Dimensions in mm (inch).

Approx. weight 0.2g

## Empfohlenes Lötpaddesign Recommended Solder Pad

## Wellenlöten (TTW) TTW Soldering

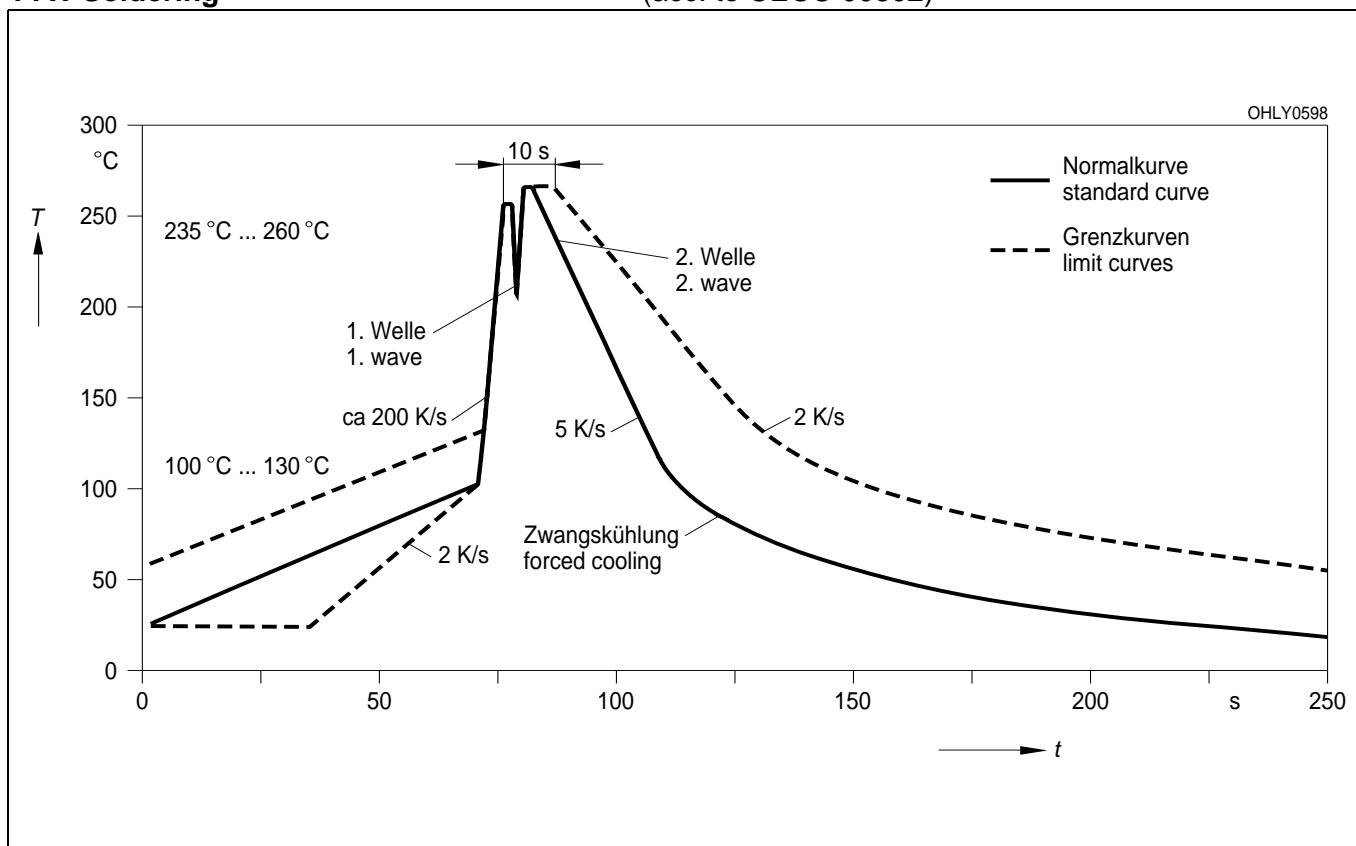


OHLPY985

Maße in mm (inch) / Dimensions in mm (inch).

**Wellenlöten (TTW)**  
**TTW Soldering**

(nach CECC 00802)  
 (acc. to CECC 00802)



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